

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination BAWOLEK ET AL.	
		Examiner José R Díaz	Art Unit 2815	Page 1 of 1

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FORM PTO-892

U.S. DEPARTMENT OF COMMERCE
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2815ATTACHMENT
TO PAPER NO.
U.S. PTO
09/524,081

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EXAMINER	DATE	
José R. Diaz	January 4, 2001	 2/22/04

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(See Manual of Patent Examining Procedure, section 707.05(a).)

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FORM PTO-892	U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE	SERIAL NO. 09/524,081	GROUP ART UNIT 2815	ATTACHMENT TO PAPER NO. 7
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